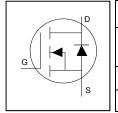




HEXFET® Power MOSFET

## **Features**

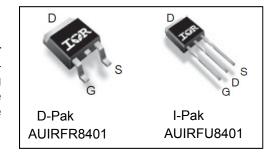
- Advanced Process Technology
- New Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



$V_{ t DSS}$	40V
R <sub>DS(on) typ.</sub>	$3.2 m\Omega$
max	4.25m $Ω$
D (Silicon Limited)	100A①
D (Package Limited)	100A

## **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low onresistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



# **Applications**

- Electric Power Steering (EPS)
- Battery Switch
- Start /Stop Micro Hybrid
- Heavy Loads
- DC-DC Converter

G	D	S
Gate	Drain	Source

**Ordering Information** 

Dage west sussibles	Dookses Tyme	Standard Pack	(	Complete Part Number
Base part number	Package Type	Form	Quantity	
AIRFR8401	D <sup>-</sup> Pak	Tube	75	AUIRFR8401
		Tape and Reel	2000	AUIRFR8401TR
		Tape and Reel Left	3000	AUIRFR8401TRL
		Tape and Reel Right	3000	AUIRFR8401TRR
AUIRFU8401	I-Pak	Tube	75	AUIRFU8401

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	100①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	71	^
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	100	_ A
I <sub>DM</sub>	Pulsed Drain Current ②	400	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation ©	79	W
	Linear Derating Factor ©	0.53	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
TJ	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		°C

 $\label{thm:hexpectation} \mbox{HEXFET} \mbox{\ensuremath{\mathbb{R}}\xspace} \mbox{ is a registered trademark of International Rectifier}.$ 

www.irf.com © 2013 International Rectifier May 06, 2013

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



## **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ③	67	m l
E <sub>AS (tested)</sub>	Single Pulse Avalanche Energy Tested Value ®	94	mJ
$I_{AR}$	Avalanche Current ②	Soc Fig 14 15 24c 24b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ②	See Fig 14, 15, 24a, 24b	mJ

## **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 9		1.9	
$R_{\theta CS}$	Junction-to-Ambient (PCB Mounted)®		50	°C/W
$R_{ hetaJA}$	Junction-to-Ambient		110	

# Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.035		V/°C	Reference to 25°C, I <sub>D</sub> = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.2	4.25	mΩ	$V_{GS} = 10V, I_D = 60A $ §
$V_{GS(th)}$	Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}$ , $I_D = 50\mu A$
$I_{DSS}$	Drain-to-Source Leakage Current			1.0	μA	$V_{DS} = 40V, V_{GS} = 0V$
				150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V
$R_G$	Internal Gate Resistance		2.0		Ω	

Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	198				$V_{DS} = 10V, I_{D} = 60A$
$Q_g$	Total Gate Charge		42	63		$I_D = 60A$
$Q_{gs}$	Gate-to-Source Charge		12		S	$V_{DS} = 20V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		14			V <sub>GS</sub> = 10V
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		28			
$t_{d(on)}$	Turn-On Delay Time		7.9			V <sub>DD</sub> = 20V
t <sub>r</sub>	Rise Time		34		no	I <sub>D</sub> = 30A
$t_{d(off)}$	Turn-Off Delay Time		25		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		24			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		2200			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		340			V <sub>DS</sub> = 25V
$C_{rss}$	Reverse Transfer Capacitance		205			f = 1.0  MHz
Coss eff. (ER)	Effective Output Capacitance		410		pF	$V_{GS}$ = 0V, $V_{DS}$ = 0V to 32V , See
	(Energy Related) ⑦					Fig. 11 ⑦
Coss eff. (TR)	Effective Output Capacitance		495			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V  $
	(Time Related)®					

#### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Package limit current is 100A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- 3 Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.037mH  $R_G$  = 50 $\Omega$ ,  $I_{AS}$  = 60A,  $V_{GS}$  =10V.
- $\$ Pulse width  $\le 400 \mu s$ ; duty cycle  $\le 2\%$ .

- $\[ \]$  Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDs is rising from 0 to 80% VDss.
- ⑦ Coss eff. (ER) is a fixed capacitance that gives the same energy as Coss while VDs is rising from 0 to 80% VDss.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \$   $\$   $\ \$   $\ \$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\$   $\$   $\ \$   $\$   $\ \$   $\$   $\$   $\$   $\ \$   $\$
- 9 This value determined from sample failure population, starting  $T_J$  = 25°C, L=0.037mH,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 60A, VGS =10V.



# **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode) ①			100①	1	MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ②			400		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 60A, V_{GS} = 0V $ (5)
dv/dt	Peak Diode Recovery dv/dt@		3.2		V/ns	$T_J = 175^{\circ}C, I_S = 60A, V_{DS} = 40V$
t	Reverse Recovery Time		28		ns	$T_{J} = 25^{\circ}C$ $V_{DD} = 34V$
L <sub>IT</sub>	The verse recovery fille		29		113	$T_{J} = 125^{\circ}C$ $I_{F} = 60A$ ,
0	Payorsa Pacayary Chargo		28		nC	<u>T<sub>J</sub> = 25°C</u> di/dt = 100A/μs ⑤
Q <sub>rr</sub>	Reverse Recovery Charge		31		1110	<u>T<sub>J</sub> = 125°C</u>
I <sub>RRM</sub>	Reverse Recovery Current		1.6		Α	$T_J = 25^{\circ}C$

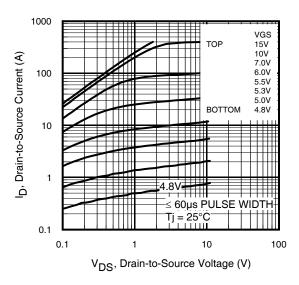


Fig 1. Typical Output Characteristics

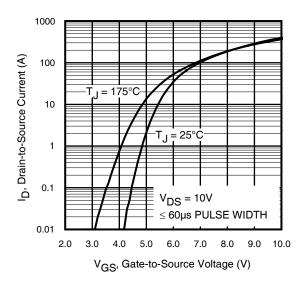


Fig 3. Typical Transfer Characteristics

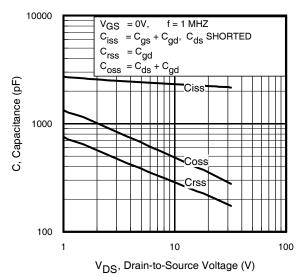


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

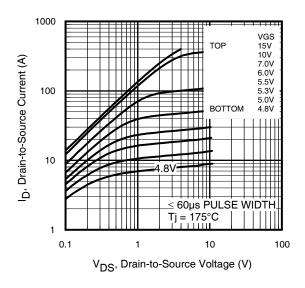


Fig 2. Typical Output Characteristics

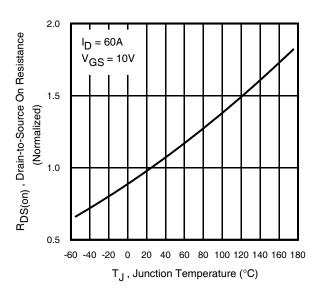


Fig 4. Normalized On-Resistance vs. Temperature

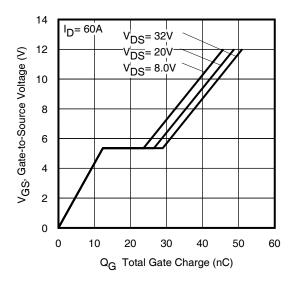


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



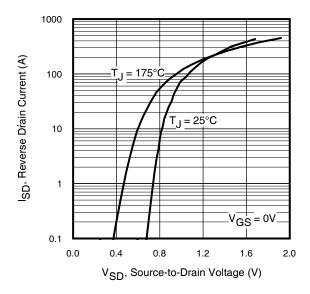


Fig 7. Typical Source-Drain Diode Forward Voltage

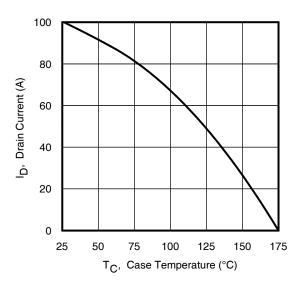


Fig 9. Maximum Drain Current vs. Case Temperature

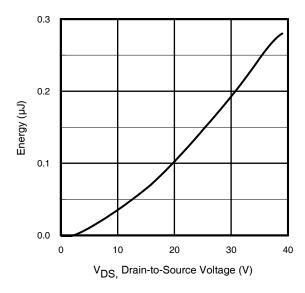


Fig 11. Typical Coss Stored Energy

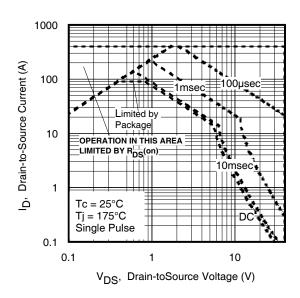


Fig 8. Maximum Safe Operating Area

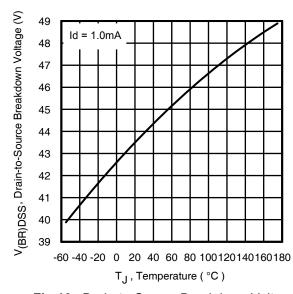


Fig 10. Drain-to-Source Breakdown Voltage

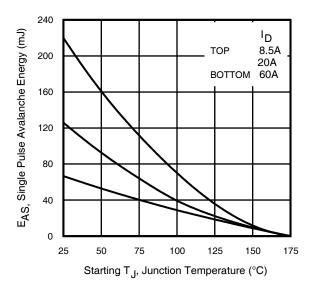


Fig 12. Maximum Avalanche Energy vs. Drain Current



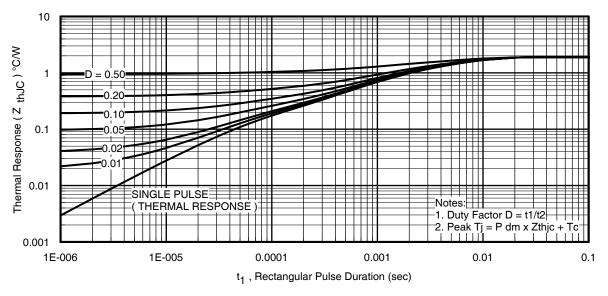


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

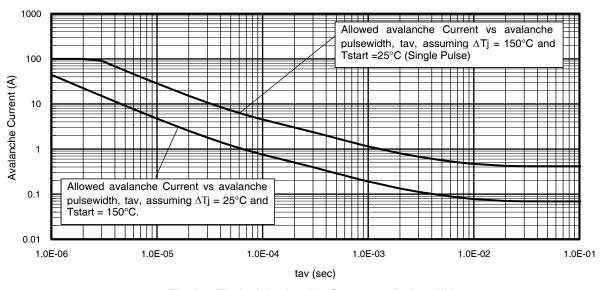


Fig 14. Typical Avalanche Current vs. Pulsewidth

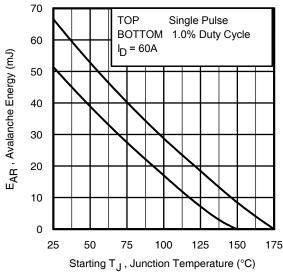


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 14, 15:

- (For further info, see AN-1005 at www.irf.com) 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asTjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed Tjmax (assumed as 25°C in Figure 14, 15).
  - t<sub>av</sub> = Average time in avalanche.
  - D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D,t_{av})$ = Transient thermal resistance, see Figures 14)

 $P_{D (ave)} = 1/2 (1.3 \cdot BV \cdot Iav) = \Delta T/Z_{thJC}$  $lav = 2\Delta T/[1.3 \cdot BV \cdot Zth]$  $E_{AS (AR)} = P_{D (ave)} \cdot t_{av}$ 



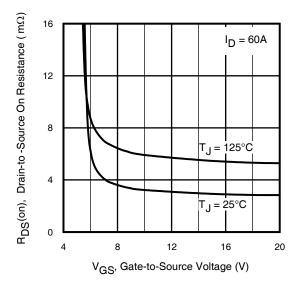


Fig 16. Typical On-Resistance vs. Gate Voltage

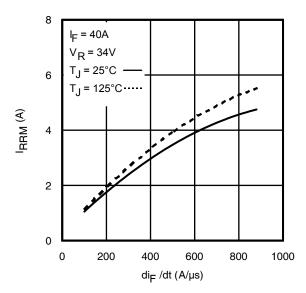


Fig. 18 - Typical Recovery Current vs. dif/dt

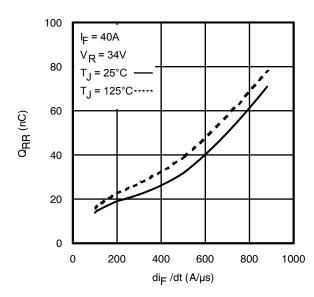


Fig. 20 - Typical Stored Charge vs. dif/dt

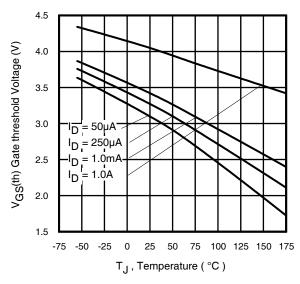


Fig 17. Threshold Voltage vs. Temperature

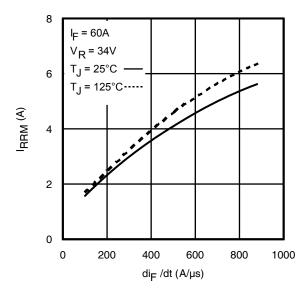


Fig. 19 - Typical Recovery Current vs. dif/dt

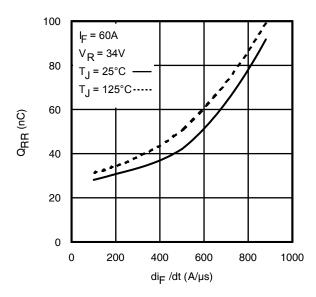


Fig. 21 - Typical Stored Charge vs. dif/dt



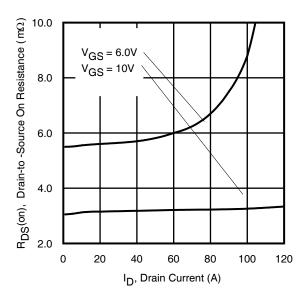


Fig 22. Typical On-Resistance vs. Drain Current



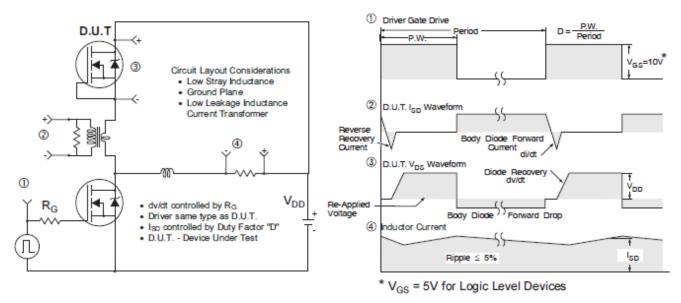


Fig 23. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

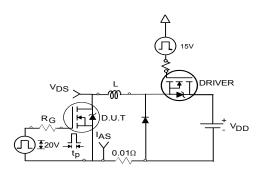


Fig 24a. Unclamped Inductive Test Circuit

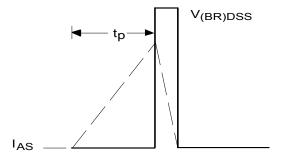


Fig 24b. Unclamped Inductive Waveforms

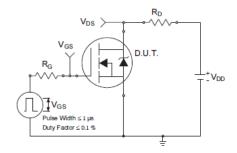


Fig 25a. Switching Time Test Circuit

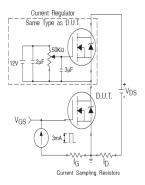


Fig 26a. Gate Charge Test Circuit

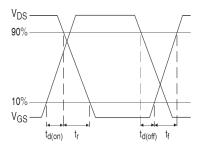


Fig 25b. Switching Time Waveforms

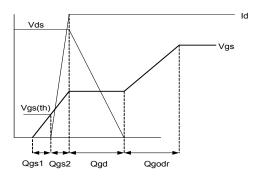
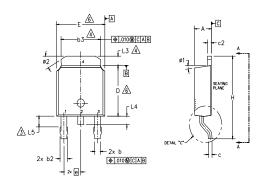


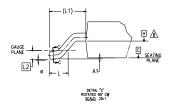
Fig 26b. Gate Charge Waveform

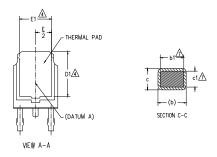
www.irf.com

## D-Pak (TO-252AA) Package Outline Dimensions are shown in millimeters (inches)









#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- ⚠ DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M			N		
B	MILLIM	ETERS	INC	HES	N O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
ь	0.64	0.89	.025	.035	
b1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	_	4
е	2.29	BSC	.090	BSC	
Н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10*	0.	10*	
ø1	0.	15*	0,	15*	
ø2	25°	35°	25*	35°	

## LEAD ASSIGNMENTS

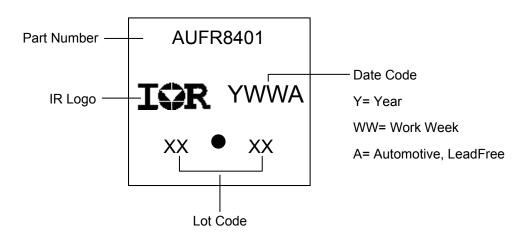
#### <u>HEXFET</u>

- 1.- GATE 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

#### IGBT & CoPAK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

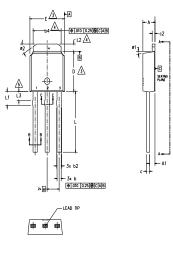
D-Pak (TO-252AA) Part Marking Information

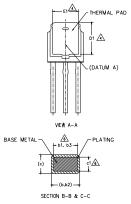


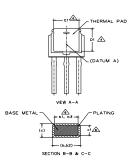
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



# I-Pak (TO-251AA) Package Outline Dimensions are shown in millimeters (inches)







#### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- $\triangle$  DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
- ⚠- LEAD DIMENSION UNCONTROLLED IN L3.
- 6- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- 7.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA (Date 06/02).
- 8.- CONTROLLING DIMENSION: INCHES.

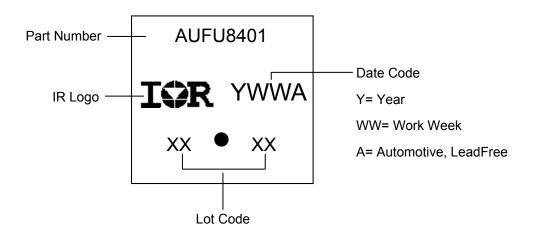
S Y M			N		
В	MILLIM	MILLIMETERS INCHES		HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	0.89	1.14	.035	.045	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	6
b2	0.76	1.14	.030	.045	
b3	0.76	1.04	.030	.041	6
b4	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	6
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	3
D1	5.21	-	.205	_	4
Ε	6.35	6.73	.250	.265	3
E1	4.32	-	.170	-	4
e	2.29	BSC	.090	BSC	
L	8.89	9.65	.350	.380	
L1	1.91	2.29	.045	.090	
L2	0.89	1.27	.035	.050	4
L3	1,14	1.52	.045	.060	5
ø1	0,	15*	0,	15*	
ø2	25°	35°	25*	35°	

LEAD ASSIGNMENTS

#### <u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

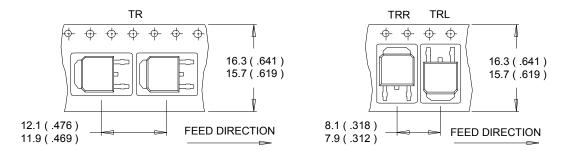
# I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

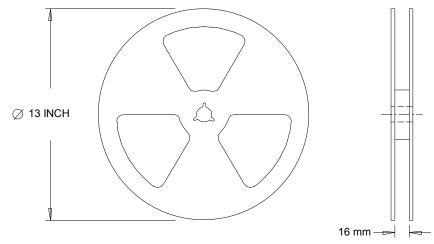


# D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



## NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



## NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>



**Qualification Information**<sup>†</sup>

			Automotive			
			(per AEC-Q101)			
Qualificati	on Level	Comments: This part number(s) passed Automotive qualific IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
		3L-D-PAK	MSL1			
Woisture S	Sensitivity Level	I-PAK	N/A			
	Machine Model		Class M2 (+/- 200) <sup>††</sup>			
			AEC-Q101-002			
	Human Body Model		Class H1C (+/- 2000) <sup>††</sup>			
ESD			AEC-Q101-001			
	Charged Device Model		Class C5 (+/- 2000) <sup>††</sup>			
			AEC-Q101-005			
RoHS Con	RoHS Compliant Yes		Yes			

Qualification standards can be found at International Rectifier's web site: http://www.irf.com/ †

<sup>††</sup> Highest passing voltage.



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